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Key indicators

Single-crystal X-ray study T = 133 K Mean σ (C–C) = 0.002 Å R factor = 0.025 wR factor = 0.057 Data-to-parameter ratio = 23.5

For details of how these key indicators were automatically derived from the article, see http://journals.iucr.org/e.

The molecule of the title compound, $C_{20}H_{16}Br_2$, displays crystallographic inversion symmetry. Two $C-H\cdots Br$ interactions link the molecules into layers parallel to (11). The

shortest Br...Br contact is 4.1599 (4) Å.

2,2"-Bis(bromomethyl)-p-terphenyl

Comment

In order to explore the relationship between brominebromine interactions and the structure of poly(bromomethyl)aryl derivatives, we have synthesized a series of bromomethylarenes. Previously, we described the structure of 1,6,7tris(bromomethyl)naphthalene (Kuś & Jones, 2003). The crystal packing of this compound shows two types of interaction: weak C-H···Br hydrogen bonds and Br···Br interactions. We describe here the crystal structure of 2,2"bis(bromomethyl)-*para*-terphenyl, (I), which was obtained by bromination of 2,2"-dimethyl-*p*-terphenyl using *N*-bromosuccinimide in boiling tetrachloromethane.

BrH₂C (I)

The molecule, which displays crystallographic inversion symmetry, is shown in Fig. 1. Bond lengths and angles may be considered normal, *e.g.* the single-bond length between the rings is 1.492 (2) Å, *cf.* 1.490 (2) Å in 2,5,2",5"-tetramethyl-*p*-terphenyl (Jones *et al.*, 2005). The angle between the central and the outer planes is 54.13 (6)°.

The molecules are linked to form layers parallel to ($\overline{111}$) by the long and presumably very weak interactions H6···Br and H7···Br (Fig. 2 and Table 1). The shortest Br···Br contact is 4.1599 (4) Å *via* the symmetry operator (-x, 1 - y, -z), which is considerably longer than the double van der Waals radius and is therefore not drawn explicitly in Fig. 2. The layers are in Received 9 August 2005 Accepted 10 August 2005 Online 17 August 2005

Secondary interactions in bromomethyl derivatives, Part 2. Part 1: Kuś & Jones (2003)

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turn linked by the short $C-H\cdots\pi$ contact $C10-H10A\cdots Cg(C4-C9)$, with C-H normalized to 1.08 Å, $H\cdots Cg = 2.71$ Å and $C-H\cdots Cg = 121^{\circ} [Cg \text{ is at } (x-1, y, z)]$. The contact is very asymmetric; the H atom is much closer to atoms C4-C7 than to the other two atoms.

Experimental

Compound (I) was synthesized from 2,2"-dimethyl-*p*-terphenyl according to the method of Boeckmann & Vögtle (1981). The analytical and spectroscopic data are consistent with the literature. Single crystals were grown by slow evaporation of a chloroform solution. ¹H NMR (CDCl₃, 400 MHz): δ 7.56–7.59 (*m*, 2H), 7.55 (*s*, 4H), 7.38–7.41 (*m*, 4H), 7.32–7.35 (*m*, 2H), 4.54 (*s*, 4H). ¹³C NMR (100 MHz): 32.42, 128.27, 128.77, 129.11, 130.64, 131.23, 135.39, 139.53, 141.75.

Z = 1

 $D_x = 1.715 \text{ Mg m}^{-3}$

Cell parameters from 4465

Rectangular prism, colourless

2348 independent reflections

2056 reflections with $I > 2\sigma(I)$

 $0.25 \times 0.10 \times 0.07 \text{ mm}$

Mo $K\alpha$ radiation

reflections $\theta = 2.7 - 30.4^{\circ}$

 $\mu=5.02~\mathrm{mm}^{-1}$

T = 133 (2) K

 $\begin{aligned} R_{\rm int} &= 0.026\\ \theta_{\rm max} &= 30.0^\circ \end{aligned}$

 $h = -6 \rightarrow 6$

 $k=-10\rightarrow 10$

 $l = -17 \rightarrow 17$

Crystal data

 $\begin{array}{l} C_{20}H_{16}Br_2 \\ M_r = 416.15 \\ \text{Triclinic, } P\overline{1} \\ a = 4.4286 \ (4) \ \text{\AA} \\ b = 7.4756 \ (6) \ \text{\AA} \\ c = 12.4664 \ (12) \ \text{\AA} \\ \alpha = 96.032 \ (4)^\circ \\ \beta = 98.347 \ (4)^\circ \\ \gamma = 96.155 \ (4)^\circ \\ V = 402.93 \ (6) \ \text{\AA}^3 \end{array}$

Data collection

Bruker SMART 1000 CCD diffractometer ω and φ scans Absorption correction: multi-scan (*SADABS*; Bruker, 1998) $T_{\rm min} = 0.488, T_{\rm max} = 0.704$ 8315 measured reflections

Refinement

Refinement on F^2	H-atom parameters constrained
$R[F^2 > 2\sigma(F^2)] = 0.025$	$w = 1/[\sigma^2(F_0^2) + (0.032P)^2]$
$wR(F^2) = 0.057$	where $P = (F_0^2 + 2F_c^2)/3$
S = 1.02	$(\Delta/\sigma)_{\rm max} < 0.001$
2348 reflections	$\Delta \rho_{\rm max} = 0.63 \ {\rm e} \ {\rm \AA}^{-3}$
100 parameters	$\Delta \rho_{\rm min} = -0.33 \text{ e } \text{\AA}^{-3}$

Table 1Hydrogen-bond geometry (Å, °).

$D - H \cdots A$	D-H	$H \cdot \cdot \cdot A$	$D \cdots A$	$D - \mathbf{H} \cdot \cdot \cdot A$
C6–H6···Br ⁱ	0.95	3.13	4.0272 (18)	158
$C7-H7\cdots Br^{n}$	0.95	3.16	3.8764 (18)	134

Symmetry codes: (i) -x, -y + 1, -z; (ii) x + 1, y + 1, z.

H atoms were included using a riding model, with C–H = 0.95 (aromatic) and 0.99 Å (methylene). $U_{\rm iso}({\rm H})$ values were fixed at $1.2U_{\rm eq}({\rm C})$.



Figure 1

The molecule of the title compound in the crystal structure. Displacement ellipsoids are drawn at the 50% probability level.



Figure 2

Packing of the title compound, viewed perpendicular to ($\overline{111}$). Dotted lines indicate C-H···Br contacts (see Comment).

Data collection: *SMART* (Bruker, 1998); cell refinement: *SAINT* (Bruker, 1998); data reduction: *SAINT*; program(s) used to solve structure: *SHELXS97* (Sheldrick, 1990); program(s) used to refine structure: *SHELXL97* (Sheldrick, 1997); molecular graphics: *XP* (Siemens, 1994); software used to prepare material for publication: *SHELXL97*.

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References

Boeckmann, K. & Vögtle, F. (1981). Liebigs Ann. Chem. pp. 467-475.

Bruker (1998). SMART (Version 5.0), SAINT (Version 4.0) and SADABS (Version 2.0). Bruker AXS Inc., Madison, Wisconsin, USA.

Jones, P. G., Kuś, P. & Pasewicz, A. (2005). Acta Cryst. E61, 01895-01896.

Kuś, P. & Jones, P. G. (2003). Acta Cryst. E**59**, 0899–0900.

Sheldrick, G. M. (1990). Acta Cryst. A46, 467-473.

Sheldrick, G. M. (1997). SHELXL97. University of Göttingen, Germany. Siemens (1994). XP. Version 5.03. Siemens Analytical X-ray Instruments Inc., Madison, Wisconsin, USA.